Reliability Engineering and System Safety **32** (1991) 375–376

CONTENTS OF VOLUME 32

Numbers 1 & 2

Preface . . . . . *v*

Issues in Developing Software for Safety Critical Systems 1
J. A. McDERMID (UK)

Design Fault Tolerance 25
J. C. KNIGHT & P. E. AMMANN (USA)

Formal Methods in the Production and Assessment of Safety Critical Software . 51
R. E. BLOOMFIELD, P. K. D. FROOME & B. Q. MONAHAN (UK)

Formal Design Verification of Digital Circuitry 67
R. W. BUTLER & J. A. SJOGREN (USA)

On the Use and the Performance of Software Reliability Growth Models . . 95
P. A. KEILLER & D. R. MILLER (USA)

Testing for the Achievement of Software Reliability 119
M. A. HENNELL (UK)

The Software Maintenance of Large Software Systems: Management, Methods and Tools 135
K. H. BENNETT (UK)

NASA Software Failure Characterization Experiments 155
G. B. FINELLI (USA)

Paradigms for Experimentation and Empirical Studies in Software Engineering . 171
V. R. BASILI & R. W. SELBY (USA)

Reliability for Defective Software 193
I. LLOYD (UK)

Index 209

Number 3

Computer-Aided Fault Tree Synthesis I (System Modeling and Causal Trees) . 217
ANDRE BOSSCHE (The Netherlands)

Reliability Engineering and System Safety **(32)** (1991)—© 1991 Elsevier Science Publishers Ltd, England. Printed in Great Britain

Times Scales and Statistical Uncertainties in the Prediction of Extreme Environmental Conditions 243
J. LABEYRIE (France)

Optimisation of Ambient Temperature in Facilities Design 267
P. H. J. VERBEEK (UK)

Reliability Analysis and Evaluation of Systems 283
O. P. GANDHI, V. P. AGRAWAL & K. S. SHISHODIA (India)

Estimation of Distribution Function and Distribution Parameter from Incomplete Data 307
LI QIANG & ZHOU ZEGONG (People's Republic of China)

Incorporating Aging Effects into Probabilistic Risk Analysis using a Taylor Expansion Approach 315
W. E. VESELY (USA)

Cost—Optimal Replacement Policy (N^*, n^*) for a Parallel System with Common Cause Failure 339
MIN-TSAI LAI & JOHN YUAN (Taiwan)

Replacement Policies Based on Minimal Repair and Cost Limit Criterion . . 349
N. L. BUTANI (India)

A Critical Review on Software Reliability Modeling 357
KAI-YUAN CAI, CHUAN-YUAN WEN & MING-LIAN ZHANG
(People's Republic of China)

Calendar 373